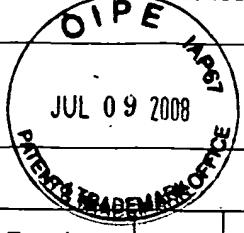


LIST OF PATENTS AND PUBLICATIONS FOR APPLICANTS' INFORMATION STATEMENT		APPLICANT Eran SHPAK	EXAMINER (N/A)
		FILING DATE January 26, 2004	GROUP ART UNIT 3679

U.S. PATENT DOCUMENTS

Examiner's Initials		DOCUMENT NO.	DATE	NAME	CLASS	SUB	FILING DATE
	AA	6,671,495	12-2003	Lappetelainen, et al.			
	AB	2004/0252696	12-2004	Kakishima, et al.			
	AC	2005/0063349	03-2005	LoGalbo, et al.			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB	TRANS- LATION
	AK						
	AL						

OTHER ART (Including Author, Bills, Pertinent Pages, Etc.)

AM		
EXAMINER:	DATE CONSIDERED:	
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.		